

<b>Notice of References Cited</b>	Application/Control No. 10/645,244	Applicant(s)/Patent Under Reexamination MEIER ET AL.	
	Examiner Shih-Chao Chen	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,670,921	12-2003	Sievenpiper et al.	343/700MS
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*	C	US-6,483,481	11-2002	Sievenpiper et al.	343/909
*	D	US-6,396,449	05-2002	Osterhues et al.	343/754
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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